

ZXTN25020DZ 20V NPN high gain transistor in SOT89

Summary

 $BV_{CEX} > 100V$

 $BV_{CEO} > 20V$

 $BV_{ECX} > 6V$

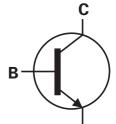
 $I_{C(cont)} = 6A$

 $V_{CE(sat)} < 48mV @ 1A$

 $R_{CE(sat)} = 30m\Omega$

 $P_D = 2.4W$

Complementary part number ZXTP25020DZ



Description

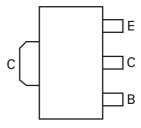
Packaged in the SOT89 outline this new low saturation 20V NPN transistor offers extremely low on state losses making it ideal for use in DC-DC circuits and various driving and power management functions

Features

- · 6 Amps continuous current
- Up to 15 Amps peak current
- · High current gain
- · Very low saturation voltages
- · 100V forward blocking voltage
- 6V reverse blocking voltage

Applications

- · Emergency lighting circuits
- Motor driving
- · Camera strobe
- · Boost converters
- · Backlight inverters
- · MOSFET gate drivers
- · LED Driving



Pinout - top view

Ordering information

Device	Reel size (inches)	Tape width (mm)	Quantity per reel
ZXTN25020DZTA	7	12	1000

Device marking

1K8

Absolute maximum ratings

Parameter	Symbol	Limit	Unit
Collector-Base voltage	V _{CBO}	100	V
Collector-Emitter voltage (forward blocking)	V _{CEX}	100	V
Collector-Emitter voltage	V _{CEO}	20	V
Emitter-Collector voltage (reverse blocking)	V _{ECX}	6	V
Emitter-Base voltage	V _{EBO}	7	V
Continuous Collector current(c)	I _C	6	Α
Base current	I _B	1	Α
Peak pulse current	I _{CM}	15	Α
Power dissipation at T _A =25°C ^(a)	P _D	1.1	W
Linear derating factor		8.8	mW/°C
Power dissipation at T _A =25°C ^(b)	P_{D}	1.8	W
Linear derating factor		14.4	mW/°C
Power dissipation at T _A =25°C ^(c)	P_{D}	2.4	W
Linear derating factor		19.2	mW/°C
Power dissipation at T _A =25°C ^(d)	P _D	4.46	W
Linear derating factor		35.7	mW/°C
Power dissipation at T _C =25°C ^(e)	P _D	19.2	W
Linear derating factor		153	mW/°C
Operating and storage temperature range	T _j , T _{stg}	-55 to 150	°C

Thermal resistance

Parameter	Symbol	Limit	Unit
Junction to ambient ^(a)	$R_{\Theta JA}$	117	°C/W
Junction to ambient ^(b)	$R_{\Theta JA}$	68	°C/W
Junction to ambient ^(c)	$R_{\Theta JA}$	51	°C/W
Junction to ambient ^(d)	$R_{\Theta JA}$	28	°C/W
Junction to case ^(e)	$R_{\Theta JC}$	7.95	°C/W

NOTES:

⁽a) For a device surface mounted on 15mm x 15mm x 0.6mm FR4 PCB with high coverage of single sided 1oz copper, in still air conditions.

⁽b) Mounted on 25mm x 25mm x 0.6mm FR4 PCB with high coverage of single sided 1oz copper, in still air conditions.

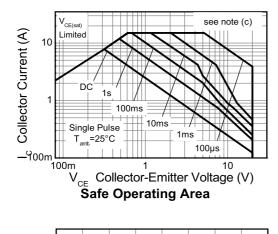
⁽c) Mounted on 50mm x 50mm x 0.6mm FR4 PCB with high coverage of single sided 2oz copper, in still air conditions.

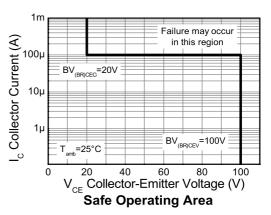
⁽d) As (c) above measured at t<5 seconds.

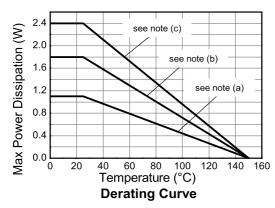
⁽e) Junction to case (collector tab. Typical

ZXTN25020DZ

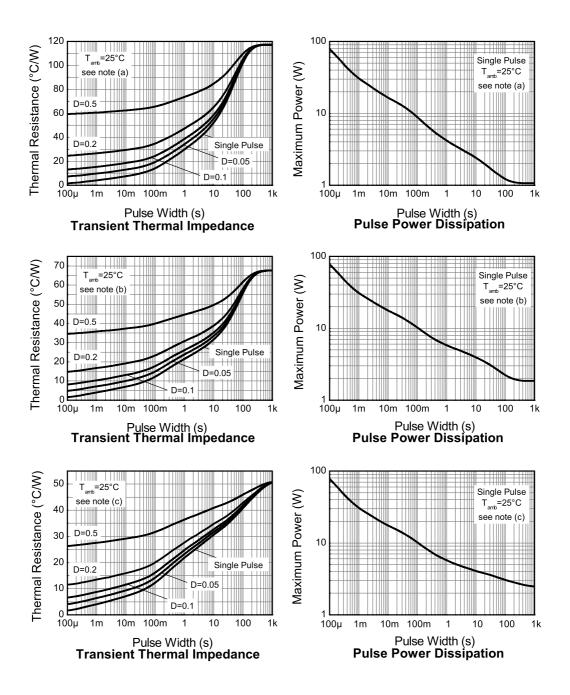
Thermal characteristics







Thermal characteristics



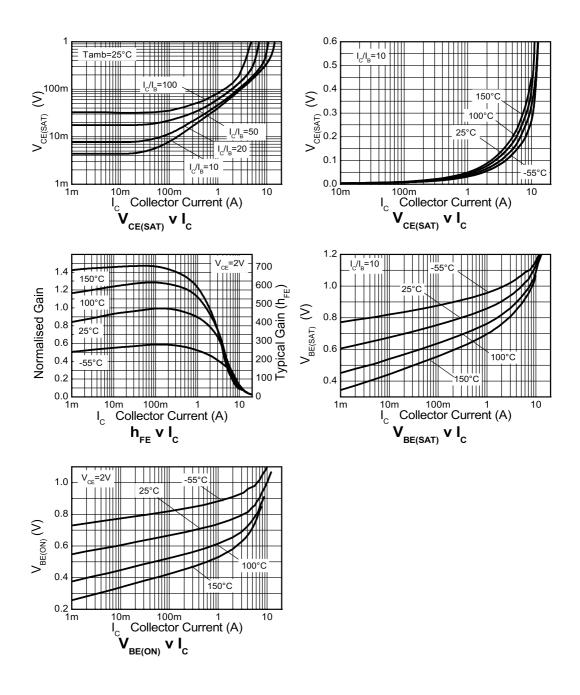
Electrical characteristics (at $T_{amb} = 25$ °C unless otherwise stated).

Collector-Base breakdown voltage Collector-Emitter collector breakdown voltage Collector-Base cut-off Collector-Emitter saturation voltage Collector-Emitter saturation voltag	Parameter	Symbol	Min.	Тур.	Max.	Unit	Conditions
Dreakdown voltage Forward blocking Forward blocking Forward blocking Forward blocking Forward blocking Forward Static forward current Forward Collector Base-Emitter cut-off current Forward Collector Base cut-off current Forward Collector Base cut-off current Forward Collector-Emitter Collector Base cut-off current Forward Collector-Emitter Cut-off Current Forward Current Forward Current Forward Current Forward Current Forward Cutrent			100	125		V	$I_C = 100 \mu A$
Dreakdown voltage Emitter-collector breakdown voltage (reverse blocking) Emitter-Collector breakdown voltage (reverse blocking) Emitter-Base breakdown voltage (reverse blocking) Emitter-Base breakdown voltage (reverse blocking) Emitter-Base breakdown voltage Collector-Base cut-off current Collector-Base cut-off current Collector-Base cut-off current Collector-Emitter saturation voltage Volume Volum	breakdown voltage		100	120		V	-1V < V _{BE} < 0.25V
Dreakdown voltage (reverse blocking) PV		BV _{CEO}	20	35		V	I _C = 10mA ^(*)
Dreakdown voltage (reverse blocking) Emitter-Base breakdown voltage Collector-Base cut-off current ICBO Collector-Base cut-off current ICEX Collector-Emitter saturation voltage VCE(sat) For the collector-Emitter saturation voltage For	breakdown voltage	BV _{ECX}	6	8		V	
Voltage Los 1 cbs Los Los Los Los Los	breakdown voltage	BV _{ECO}	5.0	6.0		V	I _E = 100μA
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$		BV _{EBO}	7.0	8.3		V	I _E = 100μA
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$		I _{CBO}		<1	50	nA	V _{CB} = 100V
current CEX Image: state of the content	current				0.5	μΑ	$V_{CB} = 100V, T_{amb} = 100^{\circ}C$
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$		I _{CEX}			100	nA	
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	Emitter cut-off current	I _{EBO}		<1	50	nA	V _{EB} = -5.6V
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$		V _{CE(sat)}		40	48	mV	$I_C = 1A$, $I_B = 100 \text{mA}^{(*)}$
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	saturation voltage			60	75	mV	
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$				100	120	mV	, <u> </u>
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$				130	180	mV	$I_C = 2A$, $I_B = 20mA^{(*)}$
$\begin{array}{c ccccccccccccccccccccccccccccccccccc$				100	120	mV	1 -
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$				210	270	mV	$I_C = 6A$, $I_B = 300 \text{mA}^{(*)}$
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$		V _{BE(sat)}		1000	1050	mV	I _C = 6A, I _B = 300mA ^(*)
		V _{BE(on)}		875	950	mV	$I_C = 6A, V_{CE} = 2V^{(*)}$
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$		h _{FE}	300	450	900		$I_C = 10 \text{mA}, V_{CE} = 2V^{(*)}$
	transfer ratio		250	360			$I_C = 2A$, $V_{CE} = 2V^{(*)}$
			50	110			0_
				15			$I_C = 15A$, $V_{CE} = 2V^{(*)}$
	Transition frequency	f _T		215		MHz	
	Input capacitance	C _{ibo}		152		pF	V _{EB} = 0.5V, f = 1MHz ^(*)
Rise time t_r 72.2 ns $I_{C} = 1A$, $V_{CC} = 10V$, $I_{B1} = -I_{B2} = 10$ mA	Output capacitance	C _{obo}		16.5	25	pF	
Storage time t_s 361 t_s	Delay time	t _d		67.7		ns	
Storage time Is 301 IIS 24 22	Rise time	t _r		72.2		ns	
Fall time t _f 63.9 ns	Storage time	t _s		361		ns	$I_{B1} = -I_{B2} = 10mA$
	Fall time	t _f		63.9		ns	1

NOTES:

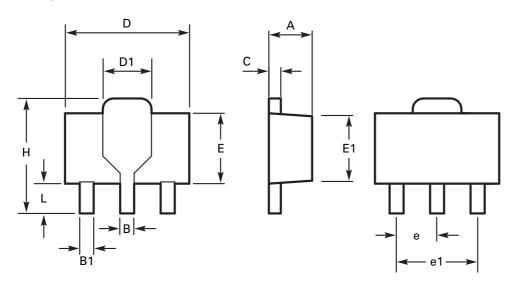
(*) Measured under pulsed conditions. Pulse width \leq 300 μ s; duty cycle \leq 2%.

Typical characteristics



ZXTN25020DZ

Package outline - SOT89



DIM	Millin	neters	Inc	hes	DIM	Millimeters		Inches	
	Min	Max	Min	Max		Min	Max	Min	Max
Α	1.40	1.60	0.550	0.630	Е	2.29	2.60	0.090	0.102
В	0.44	0.56	0.017	0.022	E1	2.13	2.29	0.084	0.090
B1	0.36	0.48	0.014	0.019	е	1.50 BSC		0.059 BSC	
С	0.35	0.44	0.014	0.017	e1	3.00	BSC	0.118	BSC
D	4.40	4.60	0.173	0.181	Н	3.94	4.25	0.155	0.167
D1	1.52	1.83	0.064	0.072	L	0.89	1.20	0.035	0.047

Note: Controlling dimensions are in millimeters. Approximate dimensions are provided in inches

ZXTN25020DZ

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